



AP/2876JW
81280PAL

Customer No. 01333

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Application of:

John T. Keech, et al

A METHOD OF LOCATING A
CALIBRATION PATCH IN A
REFERENCE CALIBRATION
TARGET

Serial No. 09/636,058

Filed 09 August 2000

Commissioner for Patents
P.O. Box 1450
Alexandria, VA. 22313-1450

Sir:

Record of Interview

The courteous telephone Interview of July 28, 2004 with Examiner St. Cyr in the above captioned application is gratefully acknowledged. During that Interview the undersigned and Examiner St. Cyr discussed the Amendment after Final. The undersigned questioned whether the decision not to enter the Amendment after Final was correct. The undersigned urged that the amendment merely inserted a dependent claim into each of the independent claims. The amendment also corrected an issue of antecedent basis in claim 1.

Examiner St. Cyr agreed that the amendment should have been entered and agreed that the Interview could serve as a record of the Amendment after Final being entered in the file.

No other issues were discussed in the telephone interview. The Examiner's consideration is again gratefully acknowledged.

Respectfully submitted,

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